


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517319	<b>Applicant(s)/Patent Under Reexamination</b>  TESSIER ET AL.
	<b>Examiner</b>  Wen, Sharon	<b>Art Unit</b>  1644

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
inventor name search PALM EAST DIALOG	8/14/2007	SW
key word search EAST DIALOG	8/14/2007	SW
priority document	8/14/2007	SW
New Matter discussed with SPE C. Chan	8/13/2007	SW
inventor name search PALM EAST DIALOG	7/15/2008	SW
key word search EAST DIALOG	7/15/2008	SW
inventor name search PALM EAST DIALOG	2/11/2009	SW
key word search EAST DIALOG	2/11/2009	SW
patentability conference with SPE O'Hara and Primary Gambel	2/12/2009	SW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	U.S. Patents and PGpubs	02/11/2009	SW

/SHARON WEN/  
Examiner,Art Unit 1644